

**Notice of References Cited**

Application/Control No.

10/567,484

Applicant(s)/Patent Under  
Reexamination  
IWASHITA ET AL.

Examiner

YEWEBDAR T. TADESSE

Art Unit

1792

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0001868	01-2005	Matsuba et al.	347/017
*	B	US-6,120,122	09-2000	Takemoto et al.	347/13
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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